IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re P	atent	Applica	ation of:			
Tae-yo	oun H	EOR et	al.			
Application No.:				Group Art Unit:		
Filed:	Febr	uary 26	5, 2004	Examiner:		
For:	COM	I PATIB	LE OPTICAL PICKUP			
			INFORMATION DISCLO	SURE STATEMENT		
PO Bo	x 145	0	Patents 313-1450			
Sir:						
subjec	ed cei t U.S.	tain inf patent	formation which the Examiner m	ovisions of 37 CFR § 1.56, there is hereby ay consider material to the examination of the the Examiner make this information of record bject application.		
	1.	Enc	losures accompanying this Infor	mation Disclosure Statement are:		
	1t 1c	a.	application or a PCT Internation English language translation (deach non-English language put Explanations of Relevancy of Research	complete or relevant portion(s)) attached to		
	2. [a concise explanation of what is presently each non-English language publication is		
	28	а. 🗌	enclosed "English-language ve indicates the degree of relevar 609, Minimum Requirements f A(3): Concise Explanation of F	is 2a, 2b, 2c and/or 2d) ish language publications were cited on the ersion of the search report or action which nee found by the foreign office". (See MPEP or an Information Disclosure Statement, Part Relevance, pp. 600-100 to 600-101, Rev. 1,		
	21	p. 🔲	Feb. 2000.) set forth in the application.			

	2d.		I to each non-	-English language publica to.	
3.	to be, m (other th	aterial to patentability r an search report(s) fro	nor a represei m a counterp	tited in this Statement is, on tation that a search has beart foreign application or a rewith). 37 CFR §§ 1.97(g	een made PCT
			Respe	ctfully submitted,	
			STAAS	S & HALSEY LLP	
Dated: F	ebruary 2	6, 2004	By:	Mula D skil	
1201 New Washing Telephon		e., N.W., Suite 700 20005 34-1500	•	Michael D. Stein Registration No. 37,240	

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. 1793.1201

APPLICATION NO.

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR

Tae-youn HEOR et al.

FILING DATE

GROUP ART UNIT

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	6,043,912	03/28/00	YOO et al.			
	AB	5,703,856	12/30/97	HAYASHI et al.			
	AC	5,235,581	08/10/93	MIYAGAWA et al.			
	AD	5,909,424	06/01/99	LEE et al.			
	AE	5,703,862	12/1997	LEE et al.			
	AF						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSI YES	LATION NO
AG							
АН							
Al							
AJ							
AK							
AL							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.